

#### Description

The Edge211 is a dual trinary driver manufactured in a wide voltage CMOS process. It is designed for automatic test equipment and instrumentation where cost, functional density, and power are all at a premium.

Each tristatable driver is capable of generating 3 levels one for a logic high, one for a logic low, and one for either a termination voltage or a special programming voltage.

The Edge211 is intended to offer an extremely low leakage, low cost, low power, small footprint, driver solution for 100 MHz and below pin electronics applications.

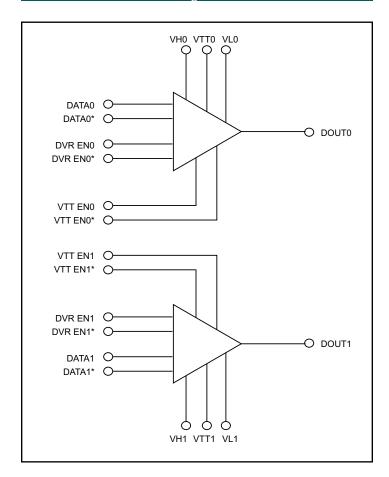
#### **Features**

- 100 MHz Operation
- 12V I/O Range
- Programmable Output Levels
- Flex In digital Inputs (Technology Independent)
- Three Level Driver
- Extremely Low Leakage Currents (~0 nA)
- Small Footprint (32 Pin, 7 mm X 7 mm, TQFP Package)

## **Applications**

Low Cost Automated Test Equipment

## Functional Block Diagram

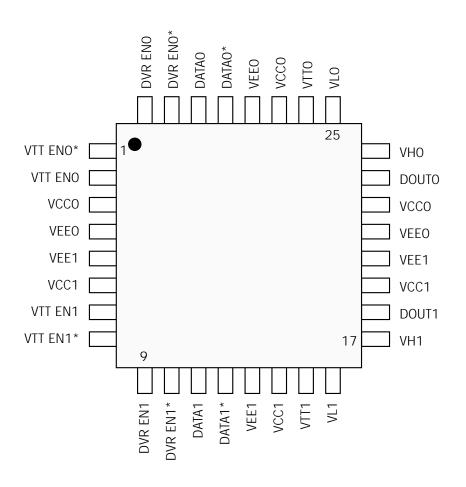




# PIN Description

| Pin Name                                 | Pin *                      | Description  |
|--|----------------------------|--|
| DATAO / DATAO*<br>DATA1 / DATA1*         | 30, 29<br>11, 12           | Digital input that determines the high/low status of the driver when it is enabled.  |
| DVR ENO / DVR ENO*<br>DVR EN1 / DVR EN1* | 32, 31<br>9, 10            | Digital input that enables and disables the driver, or places the driver in the VTT state.                                     |
| VTT ENO / VTT ENO*<br>VTT EN1 / VTT EN1* | 2, 1<br>7, 8               | Digital input that determines whether DVR EN* places the driver in a high impedance state or actively drives to the VTT level. |
| DOUTO<br>DOUT1                           | 23<br>18                   | Driver output.   |
| VHO, VH1<br>VLO, VL1<br>VTTO, VTT1       | 24, 17<br>25, 16<br>26, 15 | Unbuffered analog inputs that set the voltage level of a logical 1, 0, or VTT at the driver output.                            |
| Power Supplies                           |                            |  |
| VCC0<br>VCC1                             | 3, 22, 27<br>6, 14, 19     | Positive analog power supply.  |
| VEEO<br>VEE1                             | 4, 21, 28<br>5, 13, 20     | Negative analog power supply.  |

# PIN Description (continued)



32 Pin, 7 mm X 7 mm, TQFP Package

### Circuit Description

#### **Driver Description**

The Edge211 supports three distinct programmable driver levels – high, low, and termination, along with high impedance. There are no restrictions between any of these three levels in that all three may vary independently over the entire operating voltage range between VCC and VEE.

#### **Digital Inputs**

All digital inputs are wide voltage comparator inputs, and are therefore technology independent. The Edge211 may be driven by TTL, ECL, CMOS, or any custom level circuitry.

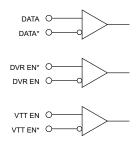


Figure 1. Driver Digital Inputs

Do NOT leave any driver digital inputs floating.

The DVR EN\*, DATA, and VTT EN are digital input pins that can be used to control the driver output level displayed at the DOUT pin.

DVR EN, DATA\*, and VTT EN\* can be connected to a reference voltage which defines the logic triggering level. The relationship between the driver control pins and their corresponding logic levels can be seen in Table 1.

| Input Voltage                               | Corresponding Logic<br>Level |
|---|------------------------------|
| V <sub>DATA</sub> > V <sub>DATA</sub> *     | DATA = 1                     |
| V <sub>DATA</sub> < V <sub>DATA</sub> *     | DATA = 0                     |
| V <sub>DVR EN</sub> > V <sub>DVR EN*</sub>  | DVR EN* = 0                  |
| V <sub>DVR EN</sub> < V <sub>DVR EN*</sub>  | DVR EN* = 1                  |
| V <sub>VTT EN</sub> > V <sub>VTT EN*</sub>  | VTT EN = 1                   |
| V <sub>VTT EN</sub> < V <sub>VTT EN</sub> * | VTT EN = O                   |

Table 1.

Using the logic levels defined in Table 1, driver functionality is described in Table 2.

| DVR EN* | VTT EN | DATA | DOUT |
|---------|--------|------|------|
| 1       | 0      | Х    | HiZ  |
| 1       | 1      | X    | VTT  |
| 0       | Х      | 0    | VL   |
| 0       | Х      | 1    | VH   |

Table 2.

Note that DVR EN\* determines whether the driver output state will be controlled by the VTT EN or the DATA pin. With DVR EN high (Logic 1), the driver output pin, DOUT, is controlled by the VTT EN pin and can be toggled between the voltage value applied at VTT, and a high impedance state. With DVR En\* low (Logic 0), DOUT can be toggled between the voltage values applied to the VL and VH pins by using the DATA input pin.

#### VH, VL, and VTT

VH, VL, and VTT define the logical "1", "0", and "termination" levels of the driver and can be adjusted anywhere over the range spanned by VCC to VEE. There is no restriction between VH, VL, and VTT, in that they can all vary independently over the entire voltage range determined by the power supply levels.

The VH, VL, and VTT inputs are unbuffered in that they also provide the driver output current, so the sources of these voltages must have ample current drive capability.

While VTT is referred to as the termination voltage, it may also be used as a very high "programming" level on many memory devices.



### Circuit Description (continued)

#### **Driver Output Protection**

The Edge211 is designed to operate in a functional testing environment where a controlled impedance (typically 50 Ohms) is maintained between the pin electronics and the DUT. In general, there will be an external resistor at the driver output which series terminates the transmission line to the DUT. In this environment, the driver can withstand a short to any legal DUT voltage for an indefinite amount of time.

In a low impedance application with no additional output series resistance, care must be exercised and systems should be designed to check for this condition and tristate the driver if a short is detected.

The driver does NOT have on-chip short circuit protection or limitation circuitry.



#### **Application Information**

#### **Power Supplies Decoupling**

A .1  $\mu\text{F}$  capacitor is recommended between VCC and VEE.

In addition, solid VCC and VEE planes are recommended to provide a low inductance path for the power supply currents. These planes will reduce any inductive supply drops associated with swtiching currents on the power supply pins. If solid planes are not possible, then wide power busses are preferable.

#### VH, VL, and VTT Decoupling

As the VH, VL, and VTT inputs are unbuffered and must supply the driver output current, decoupling capacitors for these inputs are recommended in proportion to the amount of output current the application requires. In general, a surge current of 50 mA (5V swings series terminated with 50  $\Omega$  into a 50  $\Omega$  transmission line) are the maximum dynamic output currents the driver should see. The decoupling capacitors should be able to provide this current for the duration of the round trip time between the pin electronics and the DUT, and then recharge themselves before the next such transition would occur. Once this condition is satisfied, the VH, VL, and VTT supply voltages are more responsible for establishing the DC levels associated with each function and recharging the capacitors, rather than providing the actual dynamic currents required to drive the DUT transmission line.

Ideally, VH, VL, and VTT would each have a dedicated power layer on the PC board for the lowest possible inductance power supply distribution.

#### **Power Supply Sequencing**

The following sequence should be used when powering up the Edge211.

- 1. VCC
- 2. VFF
- 3. Analog inputs (VH, VL, VTT)
- 4. Digital inputs (VTTEN, DVREN, DATA)

#### **Latchup Protection**

The Edge211 has several power supply requirements to protect the part in power supply fault situations, as well as during power up and power down sequences. VCC must remain greater than or equal to VDD (external supply for the digital logic) at all times. Both VCC and VDD must always be positive (above ground), and VEE must always be negative (at or below ground).

The three diode configuration shown in Figure 2 should be used on a once-per-board basis.

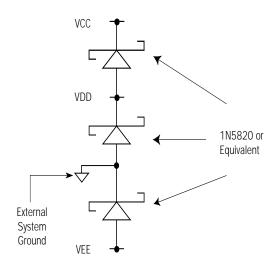
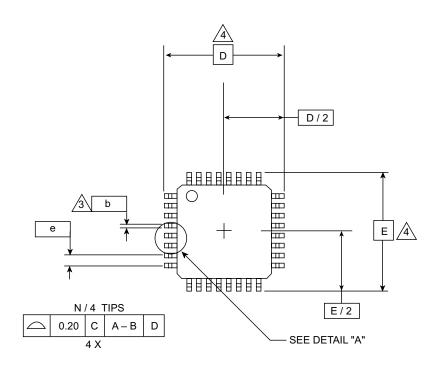


Figure 2.
Power Supply Protection Scheme

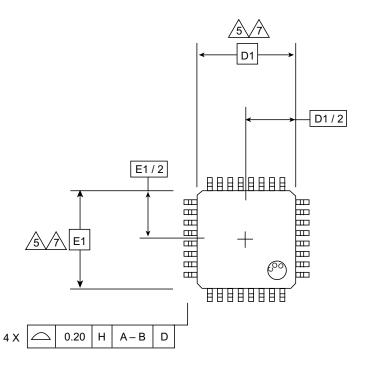
Warning: It is extremely important that the voltage on any device pin does not exceed the range of VEE -0.5V to VCC +0.5V at any time, either during power up, normal operation, or during power down. Failure to adhere to this requirement could result in latchup of the device, which could be destructive if the system power supplies are capable of supplying large amounts of current. Even if the device is not immediately destroyed, the cumulative damage caused by the stress of repeated latchup may affect device reliability.

## Package Information

#### **TOP VIEW**



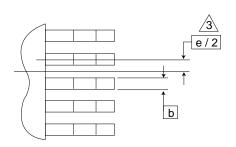
### **BOTTOM VIEW**

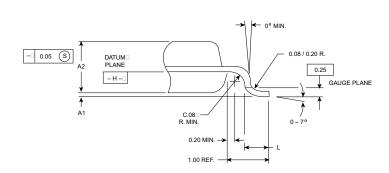




#### Package Information (continued)

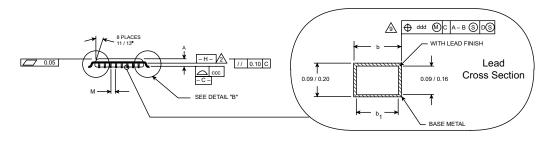
#### DETAIL "A"





**DETAIL "B"** 

#### SECTION C-C



#### Notes:

- All dimensions and tolerances conform to ANSI Y14.5-1982.
- 2. Datum plane -H- located at mold parting line and coincident with lead, where lead exits plastic body at bottom of parting line.
- Datums A-B and -D- to be determined at centerline between leads where leads exit plastic body at datum plane -H-.
- 4. To be determined at seating plane -C-.
- 5. Dimensions D1 and E1 do not include mold protrusion.
- 6. "N" is the total # of terminals.
- 7. These dimensions to be determined at the datum plane -H-.
- 8. Package top dimensions are smaller than bottom dimensions and top of package will not overhang bottom of package.
- Dimension b does not include dambar protrusion. Allowable dambar protrusion shall be 0.08 mm total in excess of the b dimension at maximum material condition. Dambar cannot be located on the lower radius or the foot.
- 10. Controlling dimension: millimeter.
- 11. Maximum allowable die thickness to be assembled in this package family is 0.30 millimeters.
- 12. This outline conforms to JEDEC publication 95, registration MO-136, variations AC, AE, and AF.

| _   |                               |      |      |      |  |
|-----|-------------------------------|------|------|------|--|
|     | JEDEC VARIATION               |      |      |      |  |
|     | All Dimensions in Millimeters |      |      |      |  |
|     |                               | AC   |      |      |  |
|     | Min.                          | Nom. | Max. | Note |  |
| Α   |                               |      | 1.60 |      |  |
| A1  | 0.05                          | 0.10 | 0.15 |      |  |
| A2  | 1.35                          | 1.40 | 1.45 |      |  |
| D   |                               | 9.00 | BSC. | 4    |  |
| D1  |                               | 7.00 | BSC. | 7,8  |  |
| E   | 9.00 BSC. 4                   |      |      |      |  |
| E1  | 7.00 BSC.                     |      |      | 7,8  |  |
| L   | 0.45                          | 0.60 | 0.75 |      |  |
| М   | 0.15                          |      |      |      |  |
| Ν   | 32                            |      |      |      |  |
| е   | 0.80 BSC.                     |      |      |      |  |
| b   | 0.30                          | 0.37 | 0.45 | 9    |  |
| b1  | 0.30                          | 0.35 | 0.40 |      |  |
| CCC |                               |      | 0.10 |      |  |
| ddd |                               |      | 0.20 |      |  |
|     |                               |      |      |      |  |



## **Recommended Operating Conditions**

| Parameter                    | Symbol    | Min | Тур | Max  | Units |
|------------------------------|-----------|-----|-----|------|-------|
| Positive Analog Power Supply | VCC       | 6   |     | 12   | V     |
| Negative Analog Power Supply | VEE       | -5  |     | -3   | V     |
| Total Analog Power Supply    | VCC - VEE | 9   |     | 12   | V     |
| Junction                     | Tj        |     |     | +125 | ° C   |

# Absolute Maximum Ratings

| Parameter                     | Symbol    | Min  | Тур | Max      | Units |
|-------------------------------|-----------|------|-----|----------|-------|
| Total Analog Power Supply     | VCC - VEE | 0    |     | 13       | V     |
| Positive Analog Power Supply  | VCC       | 0    |     | 13       | V     |
| Negative Analog Power Supply  | VEE       | -6   |     | 0        | V     |
| Analog Input Voltages         |           | VEE5 |     | VCC + .5 | V     |
| Digital Inputs                |           | VEE5 |     | VCC + .5 | V     |
| Ambient Operating Temperature | TA        | -55  |     | +125     | °C    |
| Storage Temperature           |           | -65  |     | +150     | оС    |
| Junction Temperature          | TJ        |      |     | +150     | °C    |
| Soldering Temperature         |           |      |     | 260      | °C    |

Stresses above listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



#### DC Characteristics

#### **Driver Characteristics**

| Parameter  | Symbol  | Min                           | Тур                  | Max  | Units                      |
|--|---|-------------------------------|----------------------|--|----------------------------|
| Programmable Driver Output Voltages<br>Driver Output Swing   | VH, VL, VTT<br>VH – VL<br>VH – VTT<br>VTT – VLL | VEE<br>VEE – VCC<br>VEE – VCC |                      | VCC<br>VCC – VEE<br>VCC – VEE<br>VCC – VEE | V<br>V<br>V                |
| DC Driver Output Current<br>AC Driver Output Current   | lout DC<br>lout AC                              | -50<br>-220                   |                      | +50<br>+220                                | mA<br>mA                   |
| Output Impedance<br>VH (@ +3.0V) (Note 3)<br>VTT (@ +1.5V) (Note 3)<br>VL (@ 0.0V) (Note 3)                      | Rout – HI<br>Rout – VTT<br>Rout – LOW           | 21.6<br>22.3<br>22.3          | 23.6<br>24.3<br>24.3 | 25.6<br>26.3<br>26.3                       | $\Omega \ \Omega \ \Omega$ |
| DUT Pin Capacitance (Driver Off)   | Cout  |                               | 13                   |  | pF                         |
| High Impedance Leakage Current (Note 1)  | lleak   |                               | 0                    | 4  | nA                         |
| VH / VL / VTT Offset Voltage (Note 2)  | VOS   | -100                          |                      | +100                                       | mV                         |
| VH / VL / VTT Gain and Linearity Error (Note 2)  |   | -(.5% + 5)                    |                      | +(.5% + 5)                                 | mV                         |
| Power Supply<br>Positive Supply Current<br>Negative Supply Current   | ICC<br>IEE                                      |                               | 23<br>23             | 32<br>32                                   | mA<br>mA                   |
| Total RMS Supply Current @ 80 MHz<br>AC + DC Positive Supply Current<br>AC + DC Negative Supply Current (Note 1) |   |                               | 70<br>70             |  | mA<br>mA                   |

Note 1: This parameter is guaranteed by design and characterization. Production testing is performed against a  $\pm$  250 nA limit.

Note 2: No load conditions.

*Note 3:* Tester min / max limits set to Typ  $\pm$  2.0 $\Omega$ . Tester repeatability = .8 $\Omega$ .

#### Digital Inputs DATA, DVR EN\*, VTT EN

| Parameter                   | Symbol         | Min   | Тур | Max  | Units |
|-----------------------------|----------------|-------|-----|------|-------|
| Input High Voltage          | INPUT - INPUT* | 800   |     |      | mV    |
| Input Low Voltage           | INPUT* - INPUT | 800   |     |      | mV    |
| Input Current               | IIN            |       | 0   | 1.0  | μΑ    |
| Digital Input Voltage Range | INPUT, INPUT*  | -2.0* |     | +5.0 | V     |

<sup>\* -2</sup>V or (VEE + 2.0V), whichever is more positive.



## AC Characteristics

| Parameter  | Symbol  | Min         | Тур               | Max               | Units               |
|--|---------|-------------|-------------------|-------------------|---------------------|
| Propagation Delay  DATA IN to DOUT  DVR EN* to DOUT (Active to HiZ) (Note 2)  DVR EN* to DOUT (HiZ to Active) (Note 4) |         | 7<br>7<br>7 | 11<br>11<br>11    | 14<br>14<br>15    | ns<br>ns<br>ns      |
| Minimum Pulse Width (3V Swing)   |         |             | 4                 | 5                 | ns                  |
| Toggle Rate  | Fmax    | 100         |                   |                   | MHz                 |
| DOUT Output Rise/Fall Times (Note 1) 1V Swing (20% - 80%) 3V Swing (10% - 90%) 5V Swing (10% - 90%)                    |         |             | 1.0<br>1.3<br>1.4 | 1.6<br>3.0<br>4.0 | ns<br>ns<br>ns      |
| Driver Temperature Coefficient   | ΔTpd/ΔT |             | <25               |                   | ps / <sup>o</sup> C |
| Driver Edge to Edge Matching   |         |             | <500              |                   | ps                  |
| Tpd vs. Pulse Width (Note 3)   |         |             | <100              |                   | ps                  |
| I/O Voltage Spike  |         | -500        |                   | 500               | mV                  |
| Overshoot / Undershoot   |         | - (3% + 50) |                   | + (3% + 50)       | %Swing + mV         |

Note 1: Into 18 cm of 50  $\Omega$  transmission line terminated with 1K $\Omega$  and 5 pF with the proper series termination resistor.

Note 2: Measured at a voltage change of 500 mV with a 30 mA load. (VH = +5V, VL = 0V)

Note 3: Tested with an input pulse of 20 ns, 30 ns, and 80 ns. T = 100 ns.

Note 4: 4 mA load current.



## Ordering Information

| Model Number | Package                   |
|--------------|---------------------------|
| E211ATF      | 32-Pin TQFP               |
| EVM211ATF    | Edge211 Evaluation Module |

## Contact Information

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